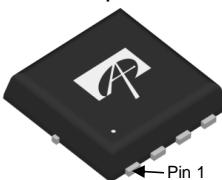
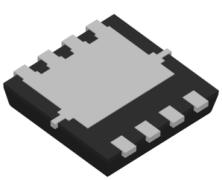
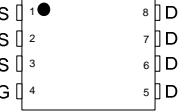
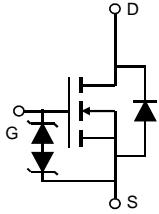


General Description		Product Summary	
<ul style="list-style-type: none"> • Low $R_{DS(ON)}$ • Optimized for Load Switch • High Current Capability • ESD Protected • RoHS and Halogen-Free Compliant 		V_{DS} 30V I_D (at $V_{GS}=10V$) 32A $R_{DS(ON)}$ (at $V_{GS}=10V$) < 4.6mΩ $R_{DS(ON)}$ (at $V_{GS}=4.5V$) < 7.2mΩ	
Applications		Typical ESD protection	HBM Class 2
<ul style="list-style-type: none"> • Battery Charging & Discharging for NB Battery Pack 		100% UIS Tested 100% R_g Tested	

Top View		DFN 3x3 EP		Bottom View		Top View					
											
Orderable Part Number		Package Type		Form		Minimum Order Quantity					
GXN7422G		DFN 3x3 EP		Tape & Reel		5000					
Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted											
Parameter		Symbol		Maximum		Units					
Drain-Source Voltage		V_{DS}		30		V					
Gate-Source Voltage		V_{GS}		± 20		V					
Continuous Drain Current ^G	$T_C=25^\circ C$	I_D		32		A					
	$T_C=100^\circ C$			32							
Pulsed Drain Current ^C		I_{DM}		118							
Continuous Drain Current	$T_A=25^\circ C$	I_{DSM}		25		A					
	$T_A=70^\circ C$			20							
Avalanche Current ^C		I_{AS}		30		A					
Avalanche energy ^C	$L=0.1mH$	E_{AS}		45		mJ					
V_{DS} Spike	10μs	V_{SPIKE}		36		V					
Power Dissipation ^B	$T_C=25^\circ C$	P_D		28		W					
	$T_C=100^\circ C$			11							
Power Dissipation ^A	$T_A=25^\circ C$	P_{DSM}		5		W					
	$T_A=70^\circ C$			3.2							
Junction and Storage Temperature Range		T_J, T_{STG}		-55 to 150		°C					

Thermal Characteristics				
Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A $t \leq 10s$	$R_{\theta JA}$	20	25	°C/W
Maximum Junction-to-Ambient ^{A,D} Steady-State		45	55	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.7	4.5
				°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	33			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1	5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			± 10	μA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.3	1.85	2.4	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$		3.8	4.6	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$		5.6	6.8	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		100		S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.7	1	V
I_S	Maximum Body-Diode Continuous Current				30	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$		2300		pF
C_{oss}	Output Capacitance			240		pF
C_{rss}	Reverse Transfer Capacitance			210		pF
R_g	Gate resistance	$f=1\text{MHz}$	1.2	2.5	4	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$		38	60	nC
$Q_g(4.5\text{V})$	Total Gate Charge			20	30	nC
Q_{gs}	Gate Source Charge			6		nC
Q_{gd}	Gate Drain Charge			12		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$		7		ns
t_r	Turn-On Rise Time			9		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			40		ns
t_f	Turn-Off Fall Time			11		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		11		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		15		nC

A. The value of $R_{\text{DS(on)}}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation $P_{\text{DS(on)}}$ is based on $R_{\text{DS(on)}} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.

D. The $R_{\text{DS(on)}}$ is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

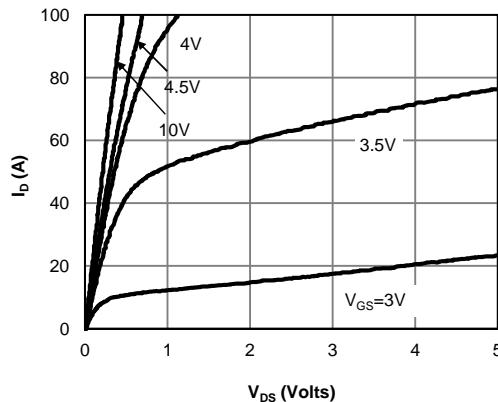


Figure 1: On-Region Characteristics (Note E)

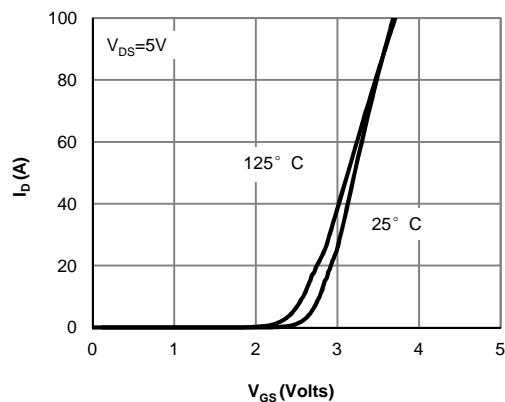


Figure 2: Transfer Characteristics (Note E)

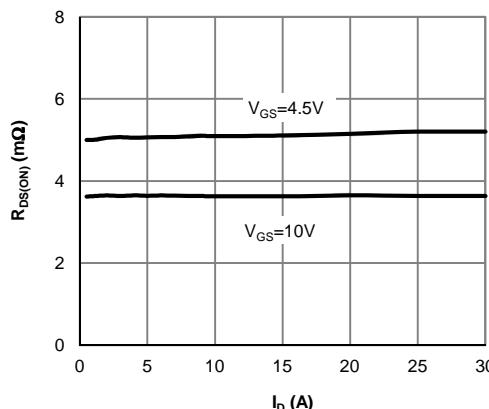


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

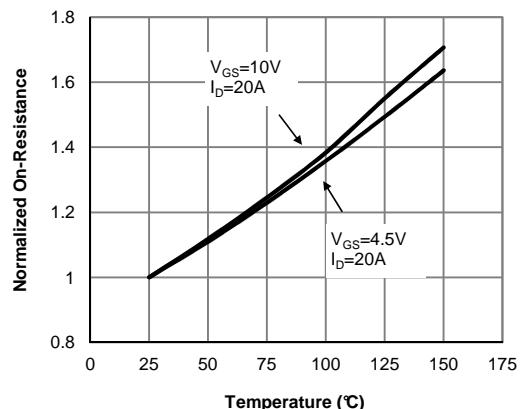


Figure 4: On-Resistance vs. Junction Temperature (Note E)

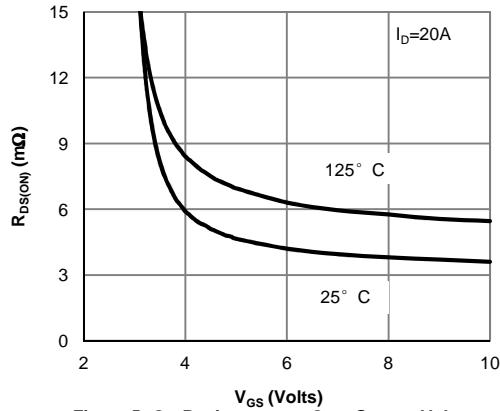


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

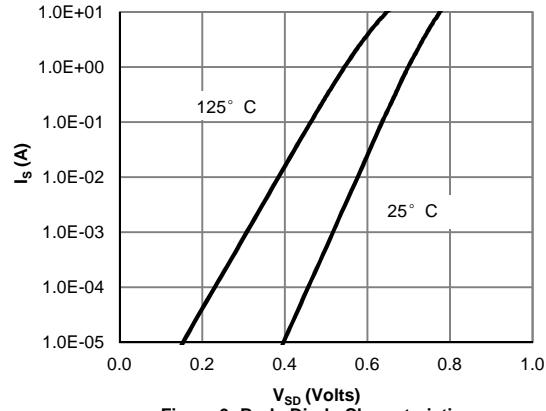


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

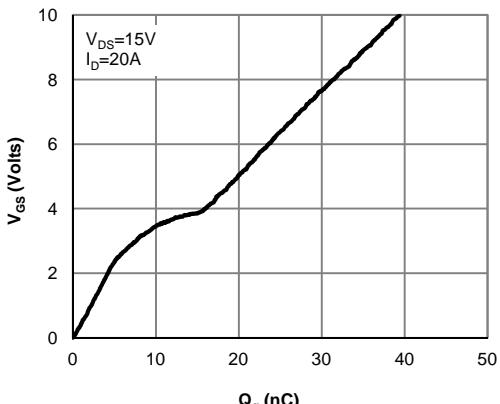


Figure 7: Gate-Charge Characteristics

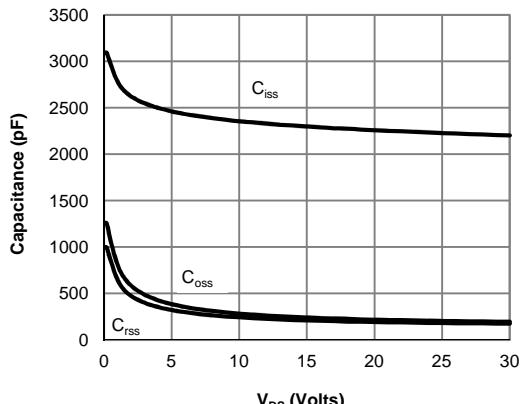


Figure 8: Capacitance Characteristics

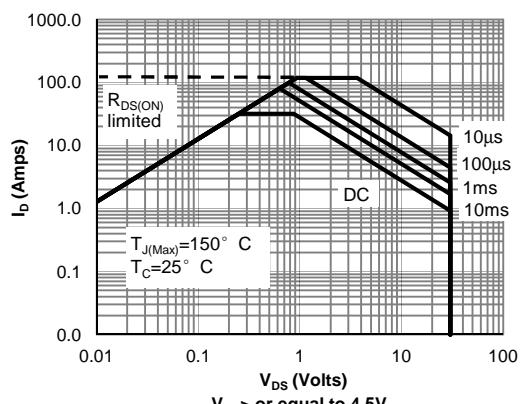


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

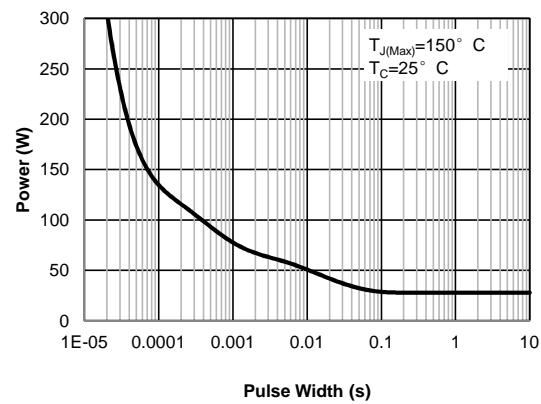


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

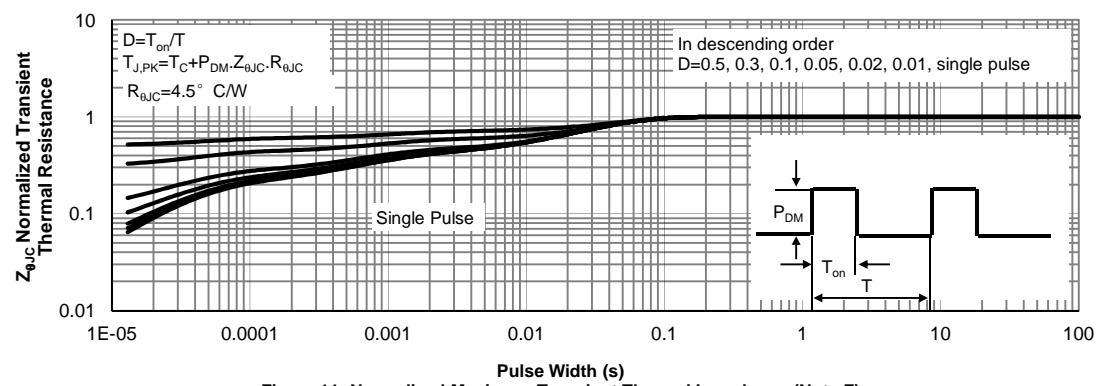


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

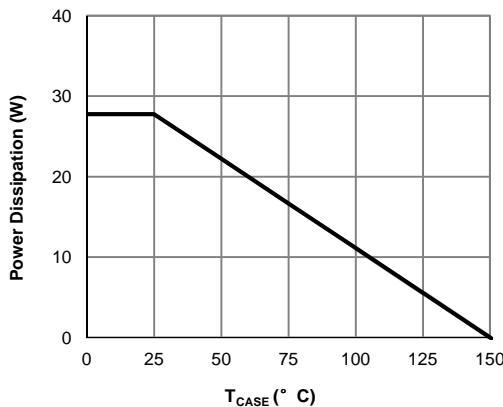


Figure 12: Power De-rating (Note F)

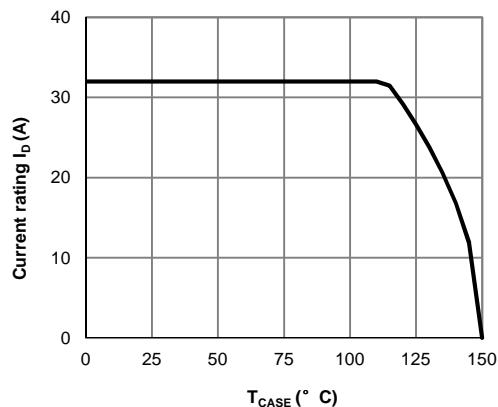


Figure 13: Current De-rating (Note F)

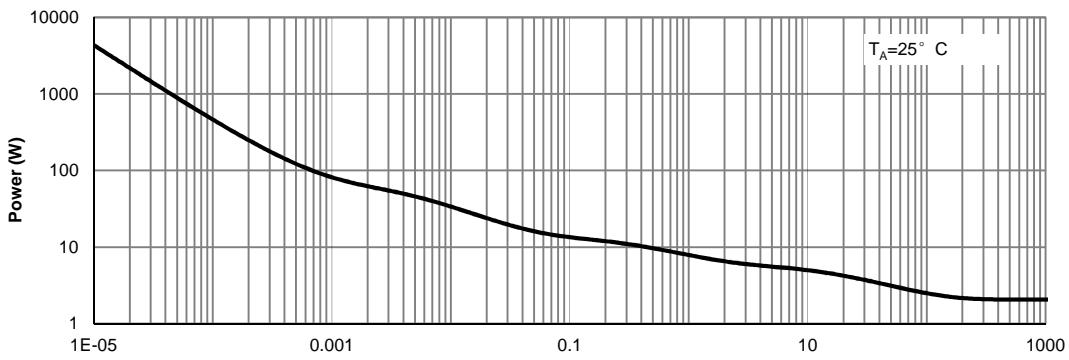


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

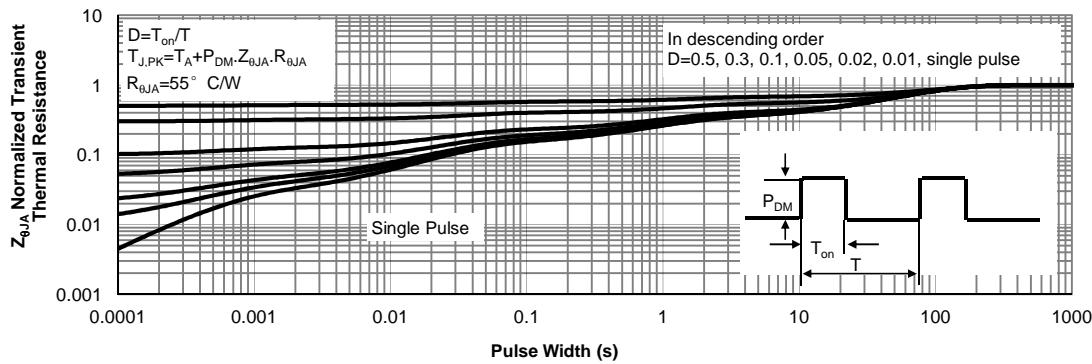


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

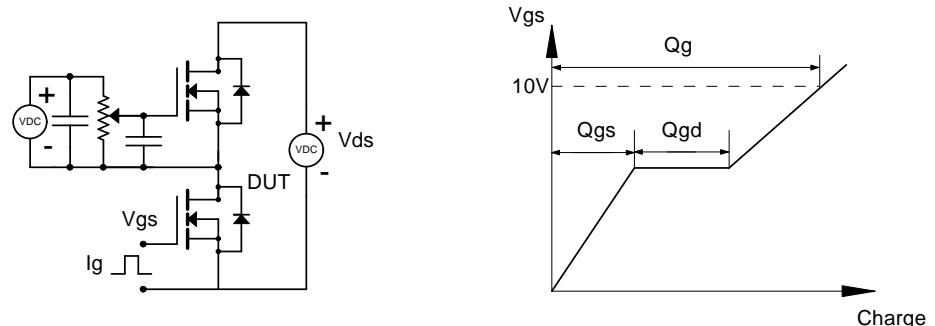


Figure B: Resistive Switching Test Circuit & Waveforms

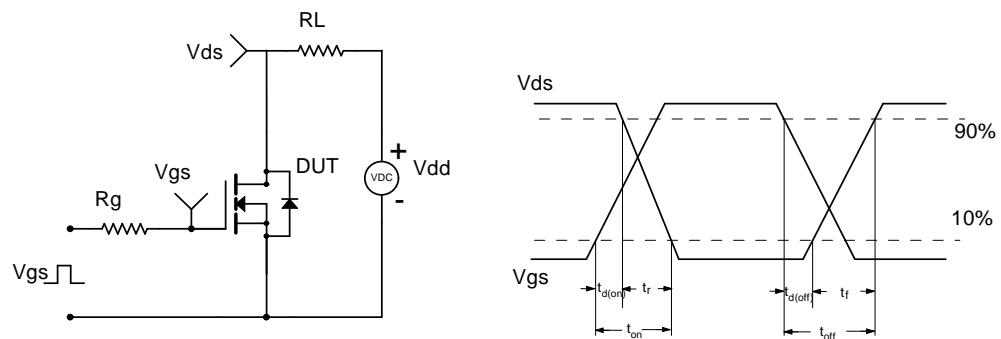


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

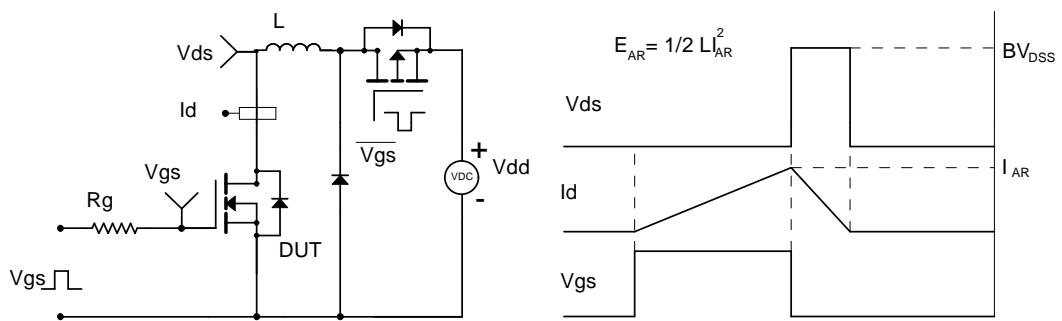


Figure D: Diode Recovery Test Circuit & Waveforms

